


<b>Search Notes</b>  	<b>Application/Control No.</b>  10560783	<b>Applicant(s)/Patent Under Reexamination</b>  EBIKO, MASAHIRO
	<b>Examiner</b>  Steven D Maki	<b>Art Unit</b>  1791

SEARCHED			
Class	Subclass	Date	Examiner
152	209.18, 209.27, 209.28, Dig. 3	03/26/08	/SM/
	updated above	10/10/08	/SM/
D12	557-567	10/11/08	/SM/
	updated above	12/20/08	/SM/

SEARCH NOTES			
Search Notes		Date	Examiner
directional and groove cross section digests kept in examiner's office		03/26/08	/SM/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	PGPUB, USPAT text search - see search history	12/20/08	/SM/

--	--